

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		Examiner	Art Unit	Page 1 of 1
		Andrew Q. Tran	2824	

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X	C	US-6,584,006 B2	06-2003	Viehmann, Hans-Heinrich	365/97
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	K	US-			
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